



Pearl Gecko

EFM32PG12 Errata



This document contains information on the errata of EFM32PG12. The latest available revision of this device is revision C.

For errata on older revisions, please refer to the errata history section for the device. The revision information is typically specified in or near the trace code on the device. Refer to the package marking information in the data sheet for more information.

Errata effective date: February, 2018.

1. Active Errata Summary

These tables list all known errata for the EFM32PG12 and all unresolved errata in revision C of the EFM32PG12.

Table 1.1. Errata History Overview

Designator	Title/Problem	Exists on Revision:		
		A	B	C
ADC_E213	ADC KEEPINSLOWACC Mode	X	X	X
ADC_E222	ADC EM2 Wakeup on a Comparator Match Disables EM2 Entry	X	—	—
ADC_E224	ADC Warm-Up Ready Can Cause IDAC, ACMP, or CSEN to Not Function	X	X	—
BL_E201	UART Bootloader Not Available	X	X	—
CUR_E203	Occasional Extra EM0/1 Current	X	X	X
DBG_E204	Debug Recovery with JTAG Does Not Work	X	X	X
DCDC_E204	Potential Brownout when Enabling the DCDC from Off to Low Power Mode	X	X	X
EMU_E209	Potential EM2 Lock-up when using IDAC or the Debugger with the LDMA	X	—	—
EMU_E212	Delay Required Between Successive Voltage Scaling Commands	X	X	X
EMU_E214	Device Erase Cannot Occur if Voltage Scaling Level is Too Low	X	X	X
RAM_E201	Timing Issues in Upper 192 KB of RAM	X	—	—
RMU_E202	External Debug Access Not Available After Watchdog or Lockup Full Reset	X	X	X
RMU_E203	AVDD Ramp Issue	X	X	—
RTCC_E203	Potential Stability Issue with RTCC Registers	X	X	X
RTCC_E204	Disabling the RTCC Backup RAM may Consume Extra Current	X	X	X
RTCC_E205	Wrap Event Can Be Missed	X	X	X
USART_E201	USART DMA Transactions Fail with Slow Peripheral Clocks	X	X	X
VDAC_E201	VDAC Output Drives All APORT Buses Simultaneously	X	X	X
VDAC_E202	PRS Outputs Not Generated when Interrupt Flag is Set	X	X	X

Table 1.2. Active Errata Status Summary

Errata #	Designator	Title/Problem	Workaround Exists	Affected Revision	Resolution
1	ADC_E213	ADC KEEPINSLOWACC Mode	No	C	—
2	CUR_E203	Occasional Extra EM0/1 Current	No	C	—
3	DBG_E204	Debug Recovery with JTAG Does Not Work	Yes	C	—
4	DCDC_E204	Potential Brownout when Enabling the DCDC from Off to Low Power Mode	Yes	C	—

Errata #	Designator	Title/Problem	Workaround Exists	Affected Revision	Resolution
5	EMU_E212	Delay Required Between Successive Voltage Scaling Commands	Yes	C	—
6	EMU_E214	Device Erase Cannot Occur if Voltage Scaling Level is Too Low	Yes	C	—
7	RMU_E202	External Debug Access Not Available After Watchdog or Lockup Full Reset	Yes	C	—
8	RTCC_E203	Potential Stability Issue with RTCC Registers	Yes	C	—
9	RTCC_E204	Disabling the RTCC Backup RAM may Consume Extra Current	Yes	C	—
10	RTCC_E205	Wrap Event Can Be Missed	Yes	C	—
11	USART_E201	USART DMA Transactions Fail with Slow Peripheral Clocks	No	C	—
12	VDAC_E201	VDAC Output Drives All APORT Buses Simultaneously	Yes	C	—
13	VDAC_E202	PRS Outputs Not Generated when Interrupt Flag is Set	Yes	C	—

2. Detailed Errata Descriptions

2.1 ADC_E213 – ADC KEEPINSLOWACC Mode

Description of Errata
When WARMUP-MODE in ADCn_CTRL is set to KEEPINSLOWACC, the ADC does not track the input voltage. Also, the ADC keeps the input muxes closed even during channel switching, making it not recommended to operate the ADC in KEEPINSLOWACC mode.
Affected Conditions / Impacts
KEEPINSLOWACC warmup mode does not function properly.
Workaround
There is currently no workaround for this issue.
Resolution
There is currently no resolution for this issue.

2.2 CUR_E203 – Occasional Extra EM0/1 Current

Description of Errata
Occasionally when exiting EM2, a low voltage oscillator sometimes continues to run and causes the device to draw an extra ~10 μ A when in EM0 or EM1. This oscillator automatically resets when entering EM2 or EM3, so the extra current draw is not present in these modes.
Affected Conditions / Impacts
Systems using EM2 may occasionally see an extra ~10 μ A of current draw in EM0 or EM1.
Workaround
There is currently no workaround for this issue.
Resolution
There is currently no resolution for this issue.

2.3 DBG_E204 – Debug Recovery with JTAG Does Not Work

Description of Errata
The debug recovery algorithm of holding down pin reset, issuing a System Bus Stall AAP instruction, and releasing the reset pin does not work when using the JTAG debug interface. When using the JTAG debug interface, the core will continue to execute code as soon as the reset pin is released.
Affected Conditions / Impacts
The debug recovery sequence will not work when using the JTAG debug interface.
Workaround
Use the Serial Wire debug interface to implement the debug recovery sequence.
Resolution
There is currently no resolution for this issue.

2.4 DCDC_E204 – Potential Brownout when Enabling the DCDC from Off to Low Power Mode

Description of Errata
A brownout event (DVDD BOD) can occur if the DC-DC converter is enabled from off to Low Power mode.
Affected Conditions / Impacts
Firmware cannot set REGPWRSEL before setting EMU->DCDCCTRL.DCDCMODE=LOWPOWER.
Workaround
<p>To workaround this issue, firmware can:</p> <ol style="list-style-type: none"> 1. Set the EMU->DCDCPWRCTRL.REGPWRSEL bitfield to 1 to select DVDD. 2. Set the EMU->DCDCCTRL.DCDCMODE bitfield to LOWNOISE. 3. Wait for the DCDCLNRRUNNING interrupt (or wait for the DCDCLNRRUNNING bit to be set in the EMU_IF register). 4. Set the EMU->DCDCCTRL.DCDCMODE bitfield to LOWPOWER. <p>This workaround is included in v5.1.0 or later of the Gecko SDK.</p>
Resolution
There is currently no resolution for this issue.

2.5 EMU_E212 – Delay Required Between Successive Voltage Scaling Commands

Description of Errata
Issuing two successive unsuccessful voltage scaling commands may cause the device to brown out.
Affected Conditions / Impacts
Systems using voltage scaling should use one of the two workarounds to avoid an undesired brown out.
Workaround
<p>There are two workarounds for this problem:</p> <ol style="list-style-type: none"> 1. Always wait for the VSCALEDONE interrupt when voltage scaling up or down. This is a very easy solution to implement, but may cause a delay of up to 25 μs of delay when scaling up and up to 3 μs of delay when scaling down. 2. For systems sensitive to delays or long voltage scaling up time: <ol style="list-style-type: none"> a. When scaling down, wait for the VSCALEDONE (or VSCALEBUSY status) interrupt (up to 3 μs of delay). b. When scaling up, successive voltage scaling commands can be issued (no 25 μs delay required). <p>Successive voltage scaling commands should never be issued when scaling down.</p> <p>This workaround is included in v5.1.0 or later of the Gecko SDK.</p>
Resolution
There is currently no resolution for this issue.

2.6 EMU_E214 – Device Erase Cannot Occur if Voltage Scaling Level is Too Low

Description of Errata
The device erase logic does not check the Voltage Scale Level prior to attempting a device erase. If using Voltage Scale Level 0 (1 V), the device may not be able to erase the flash. This results in a potentially ununlockable device if operating at Voltage Scale Level 0 (1 V).
Affected Conditions / Impacts
It is possible that the flash is only partially erased when performing the operation at Voltage Scale Level 0 (1 V). If this results in the debug lock bit not clearing, a locked part doesn't unlock after the partial erasure (which it is intended to do), and the part remains locked. If subsequent erasures continue to fail, the part would remain locked.
Workaround
<p>The voltage should be set to Voltage Scale Level 2 (1.2 V) before executing the device erase.</p> <p>For systems that don't lock the debug interface, the user can follow the debug recovery procedure to halt the CPU before it has a chance to execute code in software to avoid the code scaling the voltage. The device erase can then be executed at Voltage Scale Level 2 (1.2 V) (the power-on default voltage of the device).</p> <p>For systems that do lock the debug interface, firmware can implement a mechanism whereby it can voltage scale or unlock debug access if its defined authentication method is passed.</p>
Resolution
There is currently no resolution for this issue.

2.7 RMU_E202 – External Debug Access Not Available After Watchdog or Lockup Full Reset

Description of Errata
When a watchdog reset or lockup reset is triggered in full-reset mode (RMU_CTRL.LOCKUPRMODE or RMU_CTRL.WDOGRMODE set to FULL or 4), a debugger will not be able to read AHB-AP or ARM core registers.
Affected Conditions / Impacts
Systems using the full reset mode for watchdog or lockup resets will see limited debugging capability after one of these resets triggers.
Workaround
<p>There are two possible workarounds:</p> <ul style="list-style-type: none"> Software should configure WDOGRMODE and LOCKUPRMODE to either LIMITED or EXTENDED mode if full debugger functionality is needed after a watchdog or lockup reset. When using FULL reset mode, appending at least 9 idle clock cycles to the last debug command will allow the transaction to complete.
Resolution
There is currently no resolution for this issue.

2.8 RTCC_E203 – Potential Stability Issue with RTCC Registers

Description of Errata
RTCC_LOCK and RTCC_POWERDOWN have the potential to be momentarily unstable under some PCLK, Low Energy Peripheral Clock, and APB write scenarios. This stability issue resolves in approximately 160 ns as the write completes with the assertion of the APB clock pulse.
Affected Conditions / Impacts
A write to RTCC_LOCK or RTCC_POWERDOWN may have unintended effects if the write is completed with the Low Energy Peripheral clock enabled (RTCC in the CMU_LFECLKEN0 register is set to 1).
Workaround
To avoid this stability issue, configure the RTCC_LOCK and RTCC_POWERDOWN registers with the Low Energy Peripheral clock disabled (RTCC in the CMU_LFECLKEN0 register is cleared to 0).
This workaround is included in v5.1.0 or later of the Gecko SDK.
Resolution
There is currently no resolution for this issue.

2.9 RTCC_E204 – Disabling the RTCC Backup RAM may Consume Extra Current

Description of Errata
Disabling the RTCC backup RAM may cause higher EM4H current draw due to the internal power structure of the backup RAM.
Affected Conditions / Impacts
Systems disabling the RTCC backup RAM may see additional current consumption.
Workaround
Firmware should keep the RTCC backup RAM retained. Leakage for the backup RAM is low (~3 nA typical), so the impact is slight.
This workaround is included in v5.1.0 or later of the Gecko SDK.
Resolution
There is currently no resolution for this issue.

2.10 RTCC_E205 – Wrap Event Can Be Missed

Description of Errata
The RTCC main counter can miss a CC1 wrap event (CCV1TOP bitfield in the RTCC_CTRL register set to 1) if one of the following registers are written in the same cycle as the wrap event: RTCC_CTRL, RTCC_CNT, RTCC_TIME, RTCC_DATE, RTCC_PRECNT, RTCC_IFC, RTCC_IFS, RTCC_CCx_CCV, RTCC_CCx_CTRL, RTCC_CCx_TIME, RTCC_CCx_DATE, RTCC_CMD, RTCC_RETx_REG.
Affected Conditions / Impacts
Systems using the CC1 wrap event feature may miss events if an affected register is written immediately before a wrap occurs.
Workaround
There are two workarounds to this issue: <ul style="list-style-type: none"> Do not use the CC1 wrap event feature (CCV1TOP in RTCC_CTRL should be cleared to 0). Alternatively, do not write to any of the affected registers when the counter is about to wrap. This means that firmware must check that RTCC_CNT is not close to RTCC_CC1_CCV before writing the register.
Resolution
There is currently no resolution for this issue.

2.11 USART_E201 — USART DMA Transactions Fail with Slow Peripheral Clocks

Description of Errata
USART DMA transactions will fail when the USART peripheral clock is slower than the DMA clock and IGNORESREQ is cleared to 0.
Affected Conditions / Impacts
Systems will not be able to use the DMA with a USART running from a slow clock when IGNORESREQ is cleared to 0.
Workaround
There is currently no workaround for this issue.
Resolution
There is currently no resolution for this issue.

2.12 VDAC_E201 — VDAC Output Drives All APORT Buses Simultaneously

Description of Errata
<p>When VDACn_OPAX_OUT.APORTOUTEN is set, the VDACn/OPAx will drive all its connected APORT buses (BUSAY, BUSBY, BUSCY, and BUSDY) instead of only the APORT bus selected via APORTOUTSEL.</p> <p>The VDACn/OPAx APORT request signals do however correspond to the programmed APORTOUTSEL value, and therefore the APORT conflict registers (OPAxAPORTCONFLICT in VDACn_STATUS, OPAxAPORTCONFLICTIF in VDACn_IF, and VDACn_APORTCONFLICT) will not reflect potential conflicts on the erroneously driven APORT buses.</p> <p>If any other peripherals (or other VDAC channel or other OPAMP) are using either of the above APORT buses at the same time, this can lead to contention on the APORT bus and possible high current consumption.</p>
Affected Conditions / Impacts
Systems attempting to use multiple APORT buses and the VDAC may see contention.
Workaround
<p>If none of the other APORT clients (e.g. ADC, ACMP, OPAX input muxes, etc.) use BUSAY, BUSBY, BUSCY, and BUSDY, then no problem exists and the potential simultaneous driving of these buses by VDACn/OPAx can be ignored.</p> <p>Alternatively, the VDACn/OPAx can be configured to use direct connections of its main or alternative outputs to certain pins, thereby bypassing the APORT. Direct output connections can be enabled by programming MAINOUTEN=1 and/or ALTOUTEN=1 (while keeping APORTOUTEN=0) in the VDACn_OPAX_OUT register. The device data sheet lists the available main output and alternative output connections to pins per VDAC output or OPAMP.</p>
Resolution
There is currently no resolution for this issue.

2.13 VDAC_E202 — PRS Outputs Not Generated when Interrupt Flag is Set

Description of Errata
<p>The conversion done (CD) PRS outputs from the DAC are tied to the interrupt flags. As long as the interrupt flag is set, no PRS output will be generated.</p> <p>When the first conversion done (CD) event occurs, the VDAC will set the interrupt flag and generate one PRS pulse. As long as the interrupt flag is set, any new conversion done events will not generate a new PRS pulse. After software clears the flag, the next conversion done event will generate a PRS pulse. Clearing the interrupt flag itself will not generate a pulse. Any CD event that occurs while the flag is set will be ignored.</p>
Affected Conditions / Impacts
<p>Systems attempting to use the DAC PRS outputs should ensure the interrupt flags are cleared.</p>
Workaround
<p>Firmware should clear the conversion done flag immediately after entering the interrupt service routine. This will allow the next conversion done event to generate a PRS pulse.</p>
Resolution
<p>There is currently no resolution for this issue.</p>

3. Errata History

This section contains the errata history for EFM32PG12 devices.

For errata on latest revision, please refer to the beginning of this document. The device data sheet explains how to identify chip revision, either from package marking or electronically.

3.1 Errata History Summary

This table lists all resolved errata for the EFM32PG12.

Table 3.1. Errata History Status Summary

Errata #	Designator	Title/Problem	Workaround Exists	Affected Revision	Resolution
1	ADC_E222	ADC EM2 Wakeup on a Comparator Match Disables EM2 Entry	Yes	A	B
2	ADC_E224	ADC Warm-Up Ready Can Cause IDAC, ACMP, or CSEN to Not Function	Yes	B	C
3	BL_E201	UART Bootloader Not Available	Yes	B	C
4	EMU_E209	Potential EM2 Lock-up when using IDAC or the Debugger with the LDMA	Yes	A	B
5	RAM_E201	Timing Issues in Upper 192 KB of RAM	No	A	B
6	RMU_E203	AVDD Ramp Issue	Yes	B	C

3.2 Detailed Errata Descriptions

3.2.1 ADC_E222 – ADC EM2 Wakeup on a Comparator Match Disables EM2 Entry

Description of Errata
If the ADC wakes up the system from EM2 on a comparator flag match (CMPEN must be set in SINGLECTRL/SCANCTRL), the wake-up handler will not be able to clear this EM2 wakeup request. This results in the core immediately exiting EM2 on subsequent EM2 entry.
Affected Conditions / Impacts
Systems using the ADC comparator flag match may not be able to enter EM2.
Workaround
To clear the wakeup request, the wakeup handler must do one of the following: <ul style="list-style-type: none"> • Disable CMPEN in the SINGLECTRL/SCANCTRL register. • Reset the ADC FIFO. • Continue performing conversions until an incoming conversion does not pass the CMP threshold set in CMPTHR. Once one of these conditions has been met, the comparator can be re-enabled (if it was disabled) and the core can enter EM2.
Resolution
This issue is resolved in revision B devices.

3.2.2 ADC_E224 – ADC Warm-Up Ready Can Cause IDAC, ACMP, or CSEN to Not Function

Description of Errata
The IDAC, ACMP, or CSEN modules use the warm up timing module in the ADC to determine when the peripherals are ready for use. However, if the ADC is enabled first, this timing module can fail to properly handshake with a low probability, causing the IDAC, ACMP, or CSEN modules to never finish warming up. The ADC is not affected by this issue and will always be available after it is enabled.
Affected Conditions / Impacts
Systems using the IDAC, ACMP, or CSEN modules in conjunction with the ADC can see intermittent failures where these modules do not operate.
Workaround
To work around this issue, enable the IDAC, ACMP, or CSEN modules before enabling the ADC. This will ensure the handshaking logic between the ADC and other modules functions correctly.
Resolution
This issue is resolved in revision C devices.

3.2.3 BL_E201 – UART Bootloader Not Available

Description of Errata
The revision 0.5 data sheet mentions a UART bootloader in device flash. This bootloader is not yet available.
Affected Conditions / Impacts
Systems intending to use the pre-programmed UART bootloader will need to implement and program a bootloader to the device.
Workaround
A bootloader is not required for normal operation. However, if a bootloader is required by the application, a custom-written bootloader can be programmed on the device.
Resolution
This issue is resolved in revision C devices.

3.2.4 EMU_E209 – Potential EM2 Lock-up when using IDAC or the Debugger with the LDMA

Description of Errata
The device can lock up if firmware updates the IDAC output just before entering EM2 while the LDMA module is enabled. Similarly, the device can lock up if the Debugger is connected and the firmware enters EM2 while the LDMA module is enabled.
Affected Conditions / Impacts
Systems using the LDMA and IDAC or LDMA and Debugger may no longer function properly after attempting to enter EM2.
Workaround
Two workarounds exist: <ol style="list-style-type: none"> 1. If LDMA functionality in EM2 is not needed, firmware can disable the DMA via the CMU->HFBUSCLKEN* LDMA bit before entering EM2. 2. If LDMA functionality in EM2 is needed, wait for the IDAC output to settle before entry into EM2 or disconnect the debugger before entry into EM2.
Resolution
This issue is resolved in revision B devices.

3.2.5 RAM_E201 – Timing Issues in Upper 192 KB of RAM

Description of Errata
The upper 192 KB of internal RAM has an issue where the hold timing is not always met. This may result in DMA issues when targeting these addresses in RAM. Normal CPU accesses to data at the affected RAM addresses do not have this issue.
Affected Conditions / Impacts
This issue may result in DMA issues when targeting the upper 192 KB of internal RAM.
Workaround
DMA accesses up to the 64 KB boundary should not have any issues. There is no workaround for the upper 192 KB of RAM.
Resolution
This issue is resolved in revision B devices.

3.2.6 RMU_E203 – AVDD Ramp Issue

Description of Errata
<p>The device may not properly start during power-on or restart when a voltage droop (brown out) occurs on AVDD. The failure is intermittent.</p> <p>For example configurations and waveforms that are more likely to result in this issue, see the following Knowledge Base article:</p> <p>http://community.silabs.com/t5/32-bit-MCU-Knowledge-Base/RMU-E203-AVDD-Ramp-Issue/ta-p/197340</p> <p>To detect this failure state, place a GPIO toggle at the beginning of <code>main()</code> in the device firmware. When this failure occurs, the pin will not be toggling as expected, as the device is not executing any code.</p>
Affected Conditions / Impacts
Systems may intermittently see the device fail to start, reset, or respond. The current draw of the device in this state is ~100 µA and DECOUPLE will be fully powered (~1.2 V). The device will not execute any code in this state.
Workaround
<p>This issue can be resolved with a hardware workaround where an external circuit holds the reset pin low during power-on or brown out until AVDD reaches 1.8 V. For brown out, the reset pin must be configured to hard reset mode. This can be accomplished as part of the firmware image programmed to the device (lock bits area) or using the following code:</p> <pre>// Clears the CLW0 bit to enable Hard reset void enable_hardreset() { uint32_t value; uint32_t newvalue; value = *(uint32_t *)0xFE041E8; newvalue = value & ~(1 << 2); MSC_WriteWord((uint32_t *)0xFE041E8, &newvalue, 4); }</pre> <p>There is currently no software workaround for all potential failure mechanisms. The software workaround included in the Knowledge Base article will prevent failure in some scenarios. See the Knowledge Base article for more information:</p> <p>http://community.silabs.com/t5/32-bit-MCU-Knowledge-Base/RMU-E203-AVDD-Ramp-Issue/ta-p/197340</p>
Resolution
This issue is resolved in revision C devices.

4. Revision History

4.1 Revision 0.4

February, 2018

Updated the latest revision to revision C.

Moved [ADC_E222](#), [ADC_E224](#), [BL_E201](#), [EMU_E209](#), [RAM_E201](#), and [RMU_E203](#) to the errata history section.

4.2 Revision 0.31

June 30th, 2017

Renamed BOD_E202 to [RMU_E203](#) and adjusted the wording.

Reworded [RMU_E202](#) to remove mention of specific core architectures.

4.3 Revision 0.3

May 15th, 2017

Added [ADC_E224](#), [BL_E201](#), BOD_E202, and [RMU_E202](#).

4.4 Revision 0.2

February 20th, 2017

Updated the latest revision to revision B.

Added [DBG_E204](#), [EMU_E214](#), [USART_E201](#), [VDAC_E201](#), and [VDAC_E202](#).

Slightly adjusted the wording of the [ADC_E213](#) description.

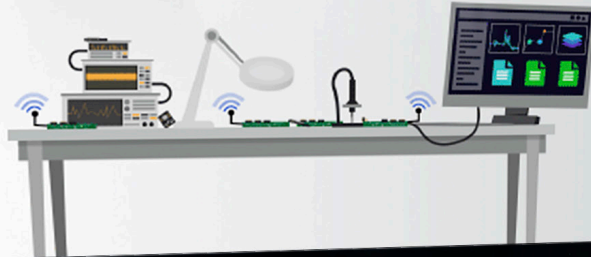
4.5 Revision 0.1

December 9th, 2016

Initial release.

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